

<b>Notice of References Cited</b>	Application/Control No. 10/500,012		Applicant(s)/Patent Under Reexamination ONAKA, KAZUHIRO	
	Examiner Jay M. Patidar		Art Unit 2862	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0130323	07-2004	Oohashi et al.	324/252
*	B	US-6,501,678	12-2002	Lenssen et al.	365/173
*	C	US-6,329,818	12-2001	Tokunaga et al.	324/252
*	D	US-5,982,178	11-1999	Pant et al.	324/252
*	E	US-5,585,719	12-1996	Endo et al.	324/235
*	F	US-4,361,805	11-1982	Narimatsu et al.	324/207.21
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.